

<b>Notice of References Cited</b>	Application/Control No. 10/782,595	Applicant(s)/Patent Under Reexamination CHIN ET AL.	
	Examiner Erika A. Gary	Art Unit 2617	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0065117	05-2002	Suda, Kei	455/574
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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**FOREIGN PATENT DOCUMENTS**

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